

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/681,143	YAMAKAWA, KENTARO	
Examiner		Art Unit		Page 1 of 1
Vincent T. Tran		2115		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,577,235	11-1996	Mitra, Sumit K.	713/600
*	B	US-2002/0066281	06-2002	Gunasekera, Darren Aster	62/186
*	C	US-5,617,007	04-1997	Keidl et al.	320/141
*	D	US-5,933,344	08-1999	Mitsuishi et al.	700/13
*	E	US-6,006,168	12-1999	Schumann et al.	702/132
*	F	US-5,293,628	03-1994	Langan et al.	713/502
*	G	US-7,113,541	09-2006	Lys et al.	375/238
*	H	US-7,098,617	08-2006	Oljaca et al.	318/268
*	I	US-4,856,078	08-1989	Konopka, John G.	388/831
*	J	US-7,098,617	08-2006	Oljaca et al.	318/268
*	K	US-2002/0005861	01-2002	Lewis, Roger	345/691
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.